

MOS FIELD EFFECT TRANSISTOR 2SK4212

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The 2SK4212 is N-channel MOS FET device that features a low on-state resistance and excellent switching characteristics, and designed for low voltage high current applications such as DC/DC converter with synchronous rectifier.

FEATURES

Low on-state resistance

 $R_{DS(on)1}$ = 7.8 m Ω MAX. (V_{GS} = 10 V, I_D = 30 A)

$$R_{DS(on)2} = 14 \text{ m}\Omega \text{ MAX.} (V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A})$$

Low total gate charge

QG = 27 nC TYP. (VDD = 15 V, VGS = 10 V, ID = 30 A)

- 4.5 V drive available
- Avalanche capability ratings

ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE		
2SK4212-ZK-E1-AY Note		Tape 2500 p/reel			
2SK4212-ZK-E2-AY Note	Pure Sn (Tin)		TO-252 (MP-3ZK) typ. 0.27 g		

Note Pb-free (This product does not contain Pb in external electrode).

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (VGs = 0 V)	VDSS	25	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	D(DC)	±48	Α
Drain Current (pulse) ^{Note1}	D(pulse)	±144	А
Total Power Dissipation (Tc = 25°C)	P _{T1}	35	W
Total Power Dissipation (T _A = 25°C)	Pt2	1.0	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	17	А
Single Avalanche Energy Note2	Eas	28.9	mJ

(TO-252)



Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1%

2. Starting Tch = 25°C, VDD = 12.5 V, RG = 25 $\Omega,$ VGS = 20 \rightarrow 0 V, L = 0.1 mH

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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 25 V, V _{GS} = 0 V			10	μA
Gate Leakage Current	lgss	V _{GS} = ±16 V, V _{DS} = 0 V			±100	nA
Gate to Source Threshold Voltage	VGS(th)	V _{DS} = V _{GS} , I _D = 250 μA	1.5		3.0	v
Forward Transfer Admittance Note	y _{fs}	V _{DS} = 5 V, I _D = 12 A	10	22		S
Drain to Source On-state Resistance ^{Note}	RDS(on)1	V _{GS} = 10 V, I _D = 30 A		5.5	7.8	mΩ
	RDS(on)2	V _{GS} = 4.5 V, I _D = 20 A		8.5	14	mΩ
Input Capacitance	Ciss	V _{DS} = 15 V,		1200		pF
Output Capacitance	Coss	V _{GS} = 0 V,		220		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		140		pF
Turn-on Delay Time	td(on)	V _{DD} = 15 V, I _D = 30 A,		16		ns
Rise Time	tr	V _{GS} = 10 V,		14		ns
Turn-off Delay Time	td(off)	Rg = 3 Ω		45		ns
Fall Time	tr			11		ns
Total Gate Charge	QG	V _{DD} = 15 V,		27		nC
Gate to Source Charge	Q _{GS}	V _{GS} = 10 V,		4		nC
Gate to Drain Charge	Qgd	ID = 30 A		7		nC
Body Diode Forward Voltage Note	VF(S-D)	IF = 30 A, VGS = 0 V		0.88	1.5	V
Reverse Recovery Time	trr	IF = 30 A, VGS = 0 V,		26		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>µ</i> s		14		nC

ELECTRICAL CHARACTERISTICS (TA = 25°C)

Note Pulsed

TEST CIRCUIT 1 AVALANCHE CAPABILITY

TEST CIRCUIT 2 SWITCHING TIME

D.U.T.

١AA

RG

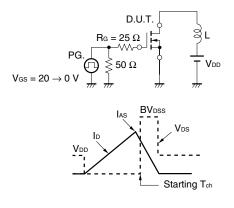
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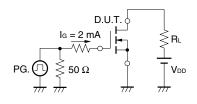
 $\tau = 1 \ \mu s$ Duty Cycle $\leq 1\%$

Vgs

0.



TEST CIRCUIT 3 GATE CHARGE



Vgs ≶r∟ 1 VGS Wave Form 0 10% Vgs VDD VDS 90% VDS VDS Wave Form 10 0 td(on) tr td(off) ton

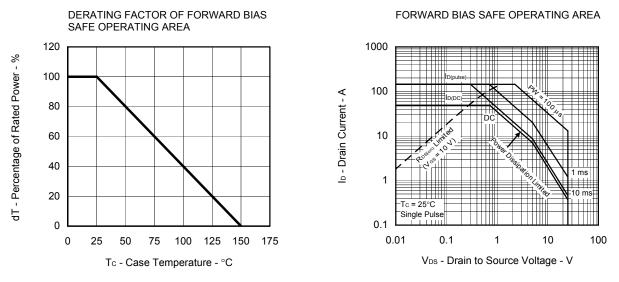
90%

90%

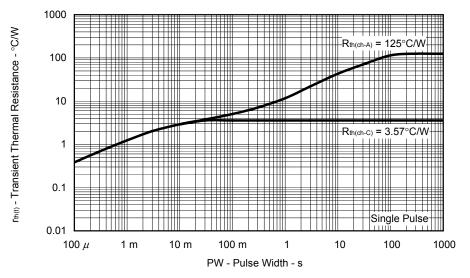
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TYPICAL CHARACTERISTICS (TA = 25°C)



TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



FORWARD TRANSFER CHARACTERISTICS

V_{DS} = 10

Pulsed

4

5

lo - Drain Current - A

30

20

10

0

0

T_A = 125°C | 75°C

1

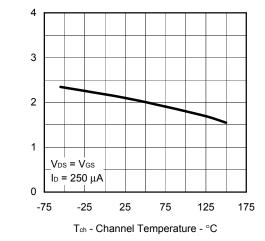
25°C

2

VGS - Gate to Source Voltage - V

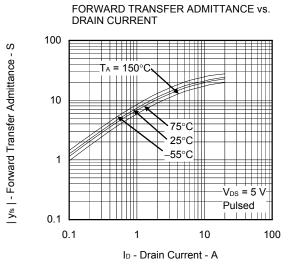
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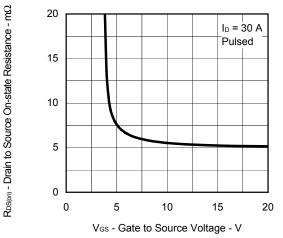


Data Sheet D19564EJ1V0DS

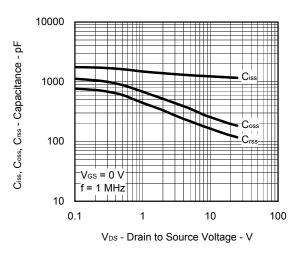
V_{GS(th)} - Gate to Source Threshold Voltage - V

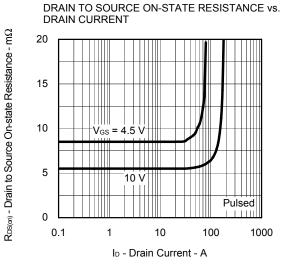


DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

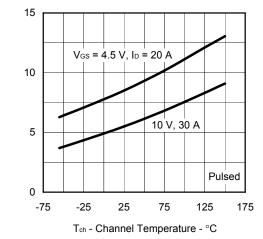


CAPACITANCE vs. DRAIN TOSOURCE VOLTAGE

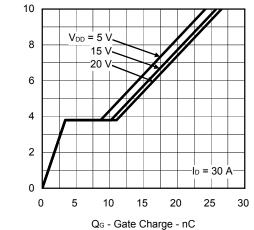




DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE

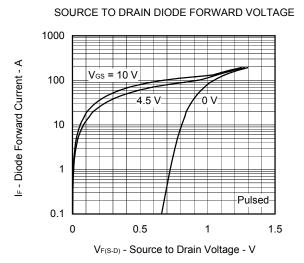


DYNAMIC INPUT/OUTPUT CHARACTERISTICS

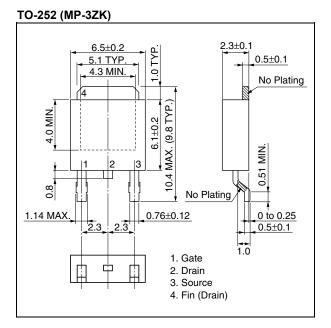


V_{GS} - Gate to Source Voltage - V

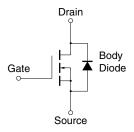
RDS(on) - Drain to Source On-state Resistance - mΩ



PACKAGE DRAWINGS (Unit: mm)



EQUIVALENT CIRCUIT



Remark Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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